

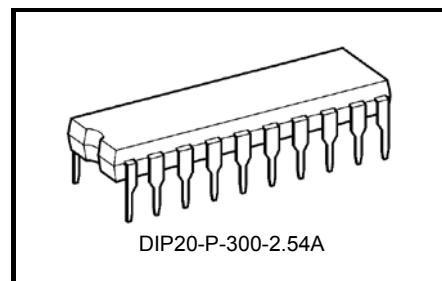
TBD62089APG

8-ch Sink Type DMOS Transistor Array with D-type Flip-Flop

The TBD62089APG is an 8-ch DMOS transistor array with D-type flip-flop. Please be careful about thermal conditions during use.

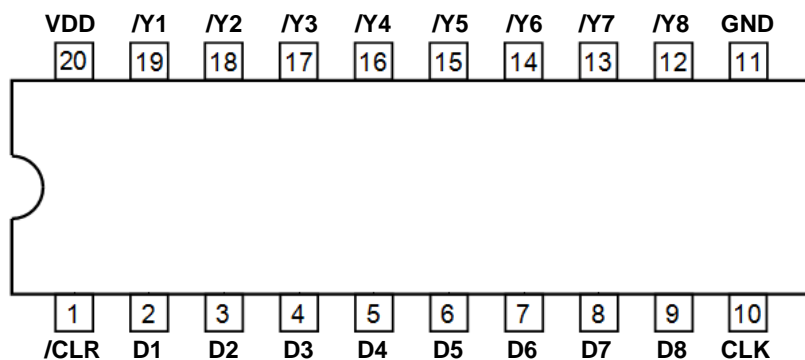
Features

- Built-in 8 circuits
- High output voltage : $V_{OUT} = 50\text{ V (max)}$
- High output current : $I_{OUT} = 500\text{ mA/ch (max)}$
- Package : DIP20-P-300-2.54A



Weight: 1.4 g (typ.)

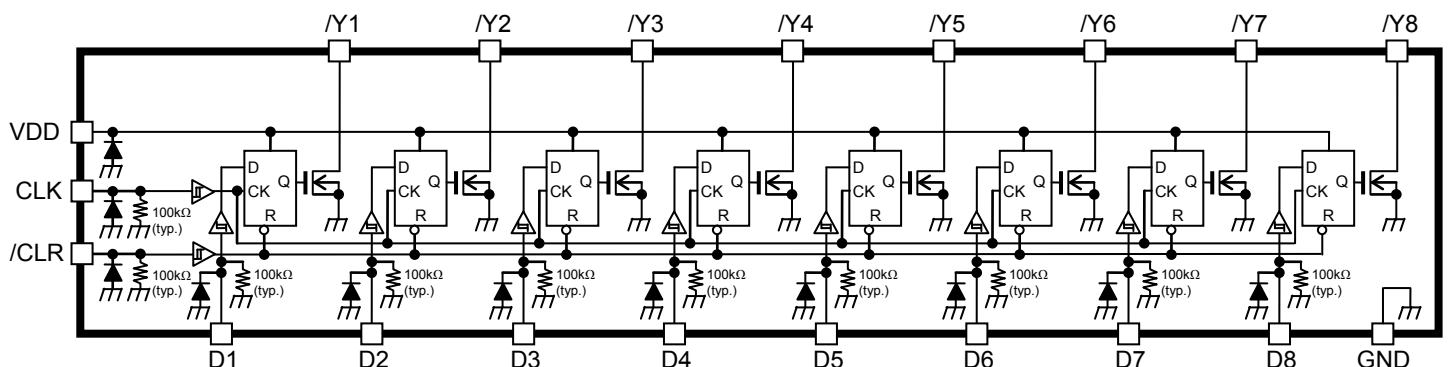
Pin assignment (top view)



Pin description

Pin No.	Pin name	Function
1	/CLR	Clear signal input pin
2	D1	Data signal input pin
3	D2	Data signal input pin
4	D3	Data signal input pin
5	D4	Data signal input pin
6	D5	Data signal input pin
7	D6	Data signal input pin
8	D7	Data signal input pin
9	D8	Data signal input pin
10	CLK	Clock signal input pin
11	GND	Ground pin
12	/Y8	Output pin
13	/Y7	Output pin
14	/Y6	Output pin
15	/Y5	Output pin
16	/Y4	Output pin
17	/Y3	Output pin
18	/Y2	Output pin
19	/Y1	Output pin
20	VDD	Power supply pin

Block diagram



Equivalent circuit may be omitted or simplified for explanatory purpose.

Function table

INPUT			OUTPUT: /Y
/CLR	CLK	D	
L	X	X	H
H	↑	L	H
H	↑	H	L
H	L	X	Y0
H	↓	X	Y0

↑: "L" to "H"

↓: "H" to "L"

H: High level

L: Low level

X: Don't care

Y0: /Y level just before inputting conditions in the table are fixed

*: Operating conditions in the table: OUTPUT is connected to the power supply through resistors.

Absolute maximum ratings ($T_a = 25^\circ\text{C}$)

Characteristics	Symbol	Rating	Unit
Output voltage	V_{OUT}	50	V
Power supply voltage	V_{DD}	-0.5 to 6	V
Output current	I_{OUT}	500	mA/ch
Input voltage	V_{IN}	-0.5 to 6	V
Power dissipation	P_{D} (Note1)	1.76 (Note2)	W
Operating temperature	T_{opr}	-40 to 85	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to 150	$^\circ\text{C}$

Note1: In mounting on a board, based on JEDEC 2s2p standards

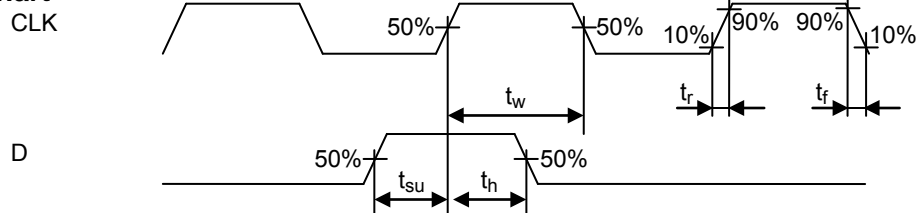
Note2: When T_a exceeds 25°C , derating with $14.1\text{ mW}/^\circ\text{C}$ is necessary.

Operating range ($T_a = -40$ to 85°C , unless otherwise specified)

Characteristics	Symbol	Test conditions	Min	Typ.	Max	Unit
Output voltage	V_{OUT}	—	—	—	50	V
Power supply voltage	V_{DD}	—	3	—	5.5	V
Output current (per channel) (Note)	I_{OUT}	1 channel ON, $T_a = 25^\circ\text{C}$	0	—	400	mA
		$t_{\text{pw}} = 25\text{ ms}$ 8 channels ON $T_a = 85^\circ\text{C}$ $T_j = 120^\circ\text{C}$ Duty = 10 %	0	—	400	
		Duty = 50 %	0	—	195	
Input voltage (Output on)	$V_{\text{IN (ON)}}$	—	$0.7 \times V_{\text{DD}}$	—	V_{DD}	V
Input voltage (Output off)	$V_{\text{IN (OFF)}}$	—	0	—	$0.3 \times V_{\text{DD}}$	V
Voltage rising time of CLK input	t_r	$V_{\text{DD}} = 3\text{ V to } 5.5\text{ V}$	0	—	500	ns
Voltage falling time of CLK input	t_f	$V_{\text{DD}} = 3\text{ V to } 5.5\text{ V}$	0	—	500	ns
Setup time	t_{su}	$V_{\text{DD}} = 3\text{ V to } 5.5\text{ V}$ Setup time of D input for CLK input	10	—	—	ns
Hold time	t_h	$V_{\text{DD}} = 3\text{ V to } 5.5\text{ V}$ Hold time of D input for CLK input	10	—	—	ns
Pulse width (CLK, /CLR)	t_w	$V_{\text{DD}} = 3\text{ V to } 5.5\text{ V}$	30	—	—	ns
Logic clock frequency	f_{CLK}	$V_{\text{DD}} = 3\text{ V to } 5.5\text{ V}$	—	—	20	MHz

Note: In mounting on a board, based on JEDEC 2s2p standards

Timing chart

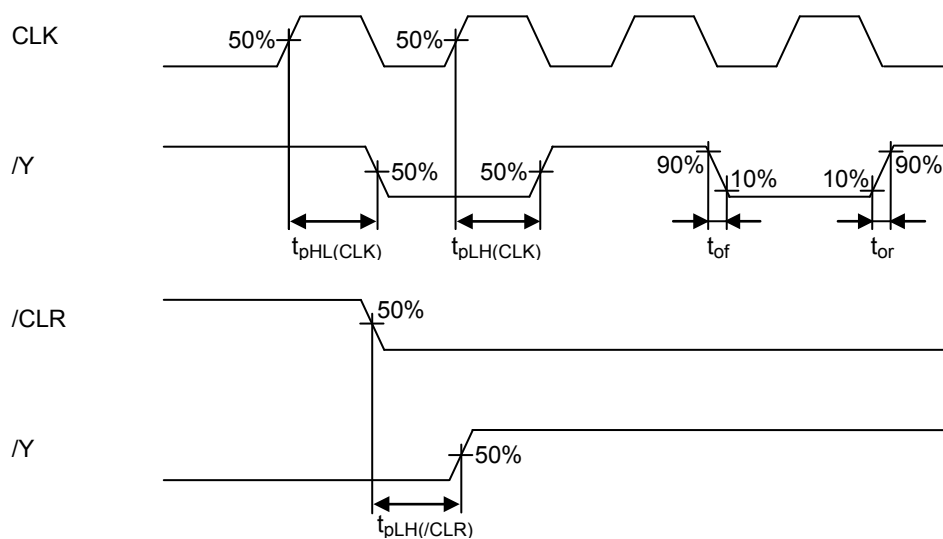


Timing charts may be omitted or simplified for explanatory purposes.

Electrical characteristics ($T_a = 25^\circ\text{C}$ and $V_{DD} = 5\text{ V}$, unless otherwise specified)

Characteristics	Symbol	Test Circuit	Test conditions	Min	Typ.	Max	Unit
Output leakage current	I_{leak}	1	$V_{OUT} = 50\text{ V}$, $T_a = 85^\circ\text{C}$ $V_{IN} = 0\text{ V}$	—	—	1.0	μA
Output voltage (Output ON-resistance)	V_{DS} (R_{ON})	2	$I_{OUT} = 350\text{ mA}$	—	0.56 (1.6)	1.14 (3.25)	V (Ω)
			$I_{OUT} = 200\text{ mA}$	—	0.32 (1.6)	0.65 (3.25)	
			$I_{OUT} = 100\text{ mA}$	—	0.16 (1.6)	0.325 (3.25)	
Input current (Output on)	$I_{IN(ON)}$	3	$V_{IN} = 5.5\text{ V}$, $V_{DD} = 5.5\text{ V}$	—	—	80	μA
Input current (Output off)	$I_{IN(OFF)}$	4	$V_{IN} = 0\text{ V}$, $V_{DD} = 5.5\text{ V}$	—	—	1.0	μA
Power supply current (per channel)	$I_{CC(ON)}$	3	$V_{IN} = 5.5\text{ V}$, $V_{DD} = 5.5\text{ V}$	—	—	75	μA
	$I_{CC(OFF)}$	4	$V_{IN} = 0\text{ V}$, $V_{DD} = 5.5\text{ V}$	—	—	1.0	μA
Propagation delay time	$t_{pHL}(\text{CLK})$	5	CLK (50 %) to /Y (50 %) /Y: H to L $C_L = 30\text{ pF}$ $R_L = 240\text{ }\Omega$, pull-up to 24 V	$V_{DD} = 4.5\text{ to }5.5\text{ V}$	—	270	ns
				$V_{DD} = 3.0\text{ to }3.6\text{ V}$	—	470	
	$t_{pLH}(\text{CLK})$	5	CLK (50 %) to /Y (50 %) /Y: L to H $C_L = 30\text{ pF}$ $R_L = 240\text{ }\Omega$, pull-up to 24 V	$V_{DD} = 4.5\text{ to }5.5\text{ V}$	—	350	ns
				$V_{DD} = 3.0\text{ to }3.6\text{ V}$	—	350	
	t_{pLH} (/CLR)	5	/CLR (50 %) to /Y (50 %) /Y: L to H $C_L = 30\text{ pF}$ $R_L = 240\text{ }\Omega$, pull-up to 24 V	$V_{DD} = 4.5\text{ to }5.5\text{ V}$	—	350	ns
				$V_{DD} = 3.0\text{ to }3.6\text{ V}$	—	350	
Turn-on delay time	t_{or}	5	/Y waveform: 10 % to 90 % $C_L = 30\text{ pF}$ $R_L = 240\text{ }\Omega$, pull-up to 24 V	$V_{DD} = 4.5\text{ to }5.5\text{ V}$	—	280	ns
				$V_{DD} = 3.0\text{ to }3.6\text{ V}$	—	280	
Turn-off delay time	t_{of}	5	/Y waveform: 90 % to 10 % $C_L = 30\text{ pF}$ $R_L = 240\text{ }\Omega$, pull-up to 24 V	$V_{DD} = 4.5\text{ to }5.5\text{ V}$	—	330	ns
				$V_{DD} = 3.0\text{ to }3.6\text{ V}$	—	620	

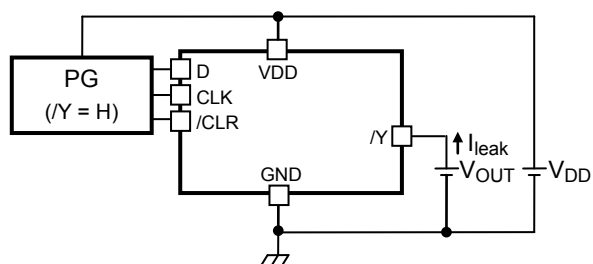
Timing chart



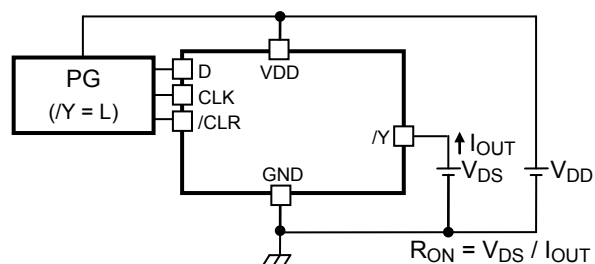
Timing charts may be omitted or simplified for explanatory purposes.

Test circuit

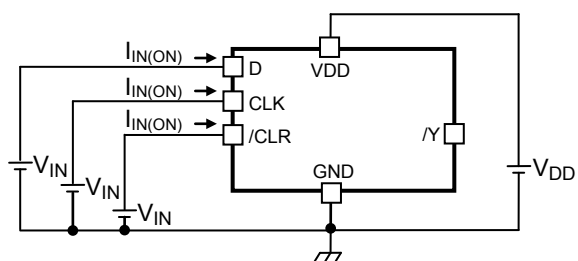
1. I_{leak}



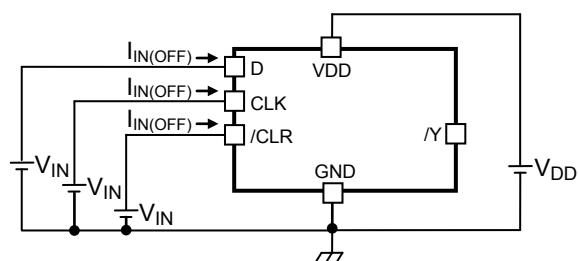
2. $V_{DS} (R_{ON})$



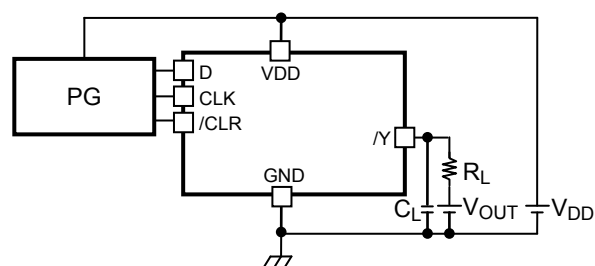
3. $I_{IN} (ON)$ and $I_{CC} (ON)$



4. $I_{IN} (OFF)$ and $I_{CC} (OFF)$



5. $t_{pHL} (CLK)$, $t_{pLH} (CLK)$, $t_{pLH} (/CLR)$, t_{or} , and t_{of}

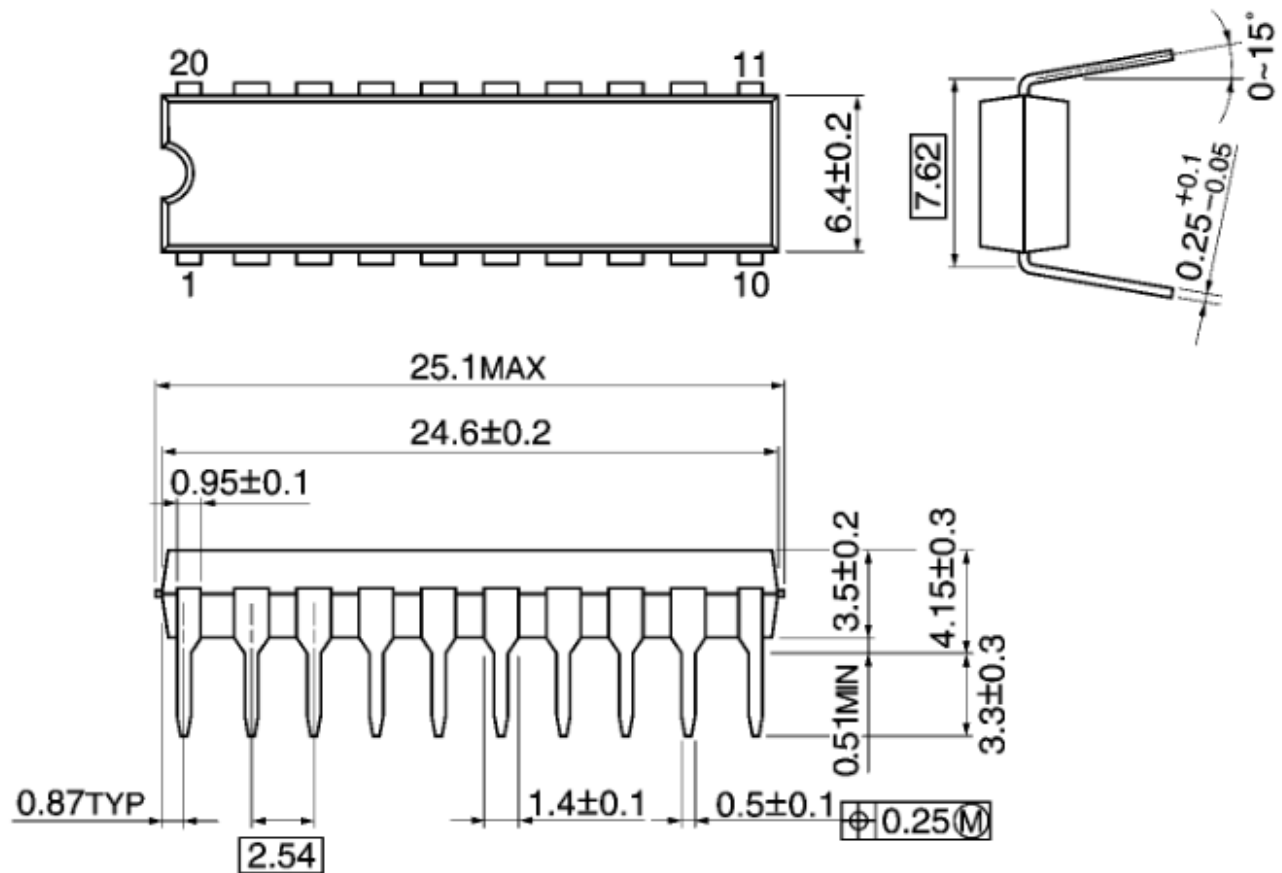


Test circuits may be omitted or simplified for explanatory purposes.

Package dimensions

DIP20-P-300-2.54A

Unit: mm



Weight: 1.4 g (typ.)

Notes on Contents

1. Block diagram

Block diagram may be simplified for explanatory purpose.

2. Test circuit

Test circuit may be simplified for explanatory purpose.

3. Timing chart

Timing charts may be simplified for explanatory purposes.

IC Usage Considerations

Notes on handling of ICs

- (1) The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings. Exceeding the rating(s) may cause device breakdown, damage or deterioration, and may result in injury by explosion or combustion.
- (2) Do not insert devices in the wrong orientation or incorrectly. Make sure that the positive and negative terminals of power supplies are connected properly. Otherwise, the current or power consumption may exceed the absolute maximum rating, and exceeding the rating(s) may cause device breakdown, damage or deterioration, and may result in injury by explosion or combustion. In addition, do not use any device inserted in the wrong orientation or incorrectly to which current is applied even just once.
- (3) Use an appropriate power supply fuse to ensure that a large current does not continuously flow in the case of overcurrent and/or IC failure. The IC will fully break down when used under conditions that exceed its absolute maximum ratings, when the wiring is routed improperly or when an abnormal pulse noise occurs from the wiring or load, causing a large current to continuously flow and the breakdown can lead to smoke or ignition. To minimize the effects of the flow of a large current in the case of breakdown, appropriate settings, such as fuse capacity, fusing time and insertion circuit location, are required.
- (4) If your design includes an inductive load such as a motor coil, incorporate a protection circuit into the design to prevent device malfunction or breakdown caused by the current resulting from the inrush current at power ON or the negative current resulting from the back electromotive force at power OFF. IC breakdown may cause injury, smoke or ignition. Use a stable power supply with ICs with built-in protection functions. If the power supply is unstable, the protection function may not operate, causing IC breakdown. IC breakdown may cause injury, smoke or ignition.
- (5) Carefully select external components (such as inputs and negative feedback capacitors) and load components (such as speakers), for example, power amp and regulator. If there is a large amount of leakage current such as from input or negative feedback condenser, the IC output DC voltage will increase. If this output voltage is connected to a speaker with low input withstand voltage, overcurrent or IC failure may cause smoke or ignition. (The overcurrent may cause smoke or ignition from the IC itself.) In particular, please pay attention when using a Bridge Tied Load (BTL) connection-type IC that inputs output DC voltage to a speaker directly.

Points to remember on handling of ICs

Heat Radiation Design

When using an IC with large current flow such as power amp, regulator or driver, design the device so that heat is appropriately radiated, in order not to exceed the specified junction temperature (T_J) at any time or under any condition. These ICs generate heat even during normal use. An inadequate IC heat radiation design can lead to decrease in IC life, deterioration of IC characteristics or IC breakdown. In addition, when designing the device, take into consideration the effect of IC heat radiation with peripheral components.

Back-EMF

When a motor rotates in the reverse direction, stops or slows abruptly, current flows back to the motor's power supply owing to the effect of back-EMF. If the current sink capability of the power supply is small, the device's motor power supply and output pins might be exposed to conditions beyond the absolute maximum ratings. To avoid this problem, take the effect of back-EMF into consideration in system design.

RESTRICTIONS ON PRODUCT USE

- Toshiba Corporation, and its subsidiaries and affiliates (collectively "TOSHIBA"), reserve the right to make changes to the information in this document, and related hardware, software and systems (collectively "Product") without notice.
- This document and any information herein may not be reproduced without prior written permission from TOSHIBA. Even with TOSHIBA's written permission, reproduction is permissible only if reproduction is without alteration/omission.
- Though TOSHIBA works continually to improve Product's quality and reliability, Product can malfunction or fail. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for their hardware, software and systems which minimize risk and avoid situations in which a malfunction or failure of Product could cause loss of human life, bodily injury or damage to property, including data loss or corruption. Before customers use the Product, create designs including the Product, or incorporate the Product into their own applications, customers must also refer to and comply with (a) the latest versions of all relevant TOSHIBA information, including without limitation, this document, the specifications, the data sheets and application notes for Product and the precautions and conditions set forth in the "TOSHIBA Semiconductor Reliability Handbook" and (b) the instructions for the application with which the Product will be used with or for. Customers are solely responsible for all aspects of their own product design or applications, including but not limited to (a) determining the appropriateness of the use of this Product in such design or applications; (b) evaluating and determining the applicability of any information contained in this document, or in charts, diagrams, programs, algorithms, sample application circuits, or any other referenced documents; and (c) validating all operating parameters for such designs and applications. **TOSHIBA ASSUMES NO LIABILITY FOR CUSTOMERS' PRODUCT DESIGN OR APPLICATIONS.**
- **PRODUCT IS NEITHER INTENDED NOR WARRANTED FOR USE IN EQUIPMENTS OR SYSTEMS THAT REQUIRE EXTRAORDINARILY HIGH LEVELS OF QUALITY AND/OR RELIABILITY, AND/OR A MALFUNCTION OR FAILURE OF WHICH MAY CAUSE LOSS OF HUMAN LIFE, BODILY INJURY, SERIOUS PROPERTY DAMAGE AND/OR SERIOUS PUBLIC IMPACT ("UNINTENDED USE").** Except for specific applications as expressly stated in this document, Unintended Use includes, without limitation, equipment used in nuclear facilities, equipment used in the aerospace industry, medical equipment, equipment used for automobiles, trains, ships and other transportation, traffic signaling equipment, equipment used to control combustions or explosions, safety devices, elevators and escalators, devices related to electric power, and equipment used in finance-related fields. **IF YOU USE PRODUCT FOR UNINTENDED USE, TOSHIBA ASSUMES NO LIABILITY FOR PRODUCT.** For details, please contact your TOSHIBA sales representative.
- Do not disassemble, analyze, reverse-engineer, alter, modify, translate or copy Product, whether in whole or in part.
- Product shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable laws or regulations.
- The information contained herein is presented only as guidance for Product use. No responsibility is assumed by TOSHIBA for any infringement of patents or any other intellectual property rights of third parties that may result from the use of Product. No license to any intellectual property right is granted by this document, whether express or implied, by estoppel or otherwise.
- **ABSENT A WRITTEN SIGNED AGREEMENT, EXCEPT AS PROVIDED IN THE RELEVANT TERMS AND CONDITIONS OF SALE FOR PRODUCT, AND TO THE MAXIMUM EXTENT ALLOWABLE BY LAW, TOSHIBA (1) ASSUMES NO LIABILITY WHATSOEVER, INCLUDING WITHOUT LIMITATION, INDIRECT, CONSEQUENTIAL, SPECIAL, OR INCIDENTAL DAMAGES OR LOSS, INCLUDING WITHOUT LIMITATION, LOSS OF PROFITS, LOSS OF OPPORTUNITIES, BUSINESS INTERRUPTION AND LOSS OF DATA, AND (2) DISCLAIMS ANY AND ALL EXPRESS OR IMPLIED WARRANTIES AND CONDITIONS RELATED TO SALE, USE OF PRODUCT, OR INFORMATION, INCLUDING WARRANTIES OR CONDITIONS OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, ACCURACY OF INFORMATION, OR NONINFRINGEMENT.**
- Do not use or otherwise make available Product or related software or technology for any military purposes, including without limitation, for the design, development, use, stockpiling or manufacturing of nuclear, chemical, or biological weapons or missile technology products (mass destruction weapons). Product and related software and technology may be controlled under the applicable export laws and regulations including, without limitation, the Japanese Foreign Exchange and Foreign Trade Law and the U.S. Export Administration Regulations. Export and re-export of Product or related software or technology are strictly prohibited except in compliance with all applicable export laws and regulations.
- Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product. Please use Product in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. **TOSHIBA ASSUMES NO LIABILITY FOR DAMAGES OR LOSSES OCCURRING AS A RESULT OF NONCOMPLIANCE WITH APPLICABLE LAWS AND REGULATIONS.**